

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination CHIU, CHUI-KUEI	
	Examiner Cheukfan Lee	Art Unit 2622	Page 1 of 1

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L	US-			
M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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